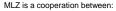


Reflectometry in BornAgain: overview

Dmitry Yurov











Helmholtz equation

• Schrödinger equation:

$$\left[-\frac{\hbar^2}{2m}\Delta + U \right] \psi = i\hbar \frac{\partial \psi}{\partial t}$$

Electromagnetic wave equation:

$$\Delta \vec{E} = \frac{\epsilon \mu}{c^2} \frac{\partial^2 \vec{E}}{\partial t^2}$$

$$\frac{\partial U}{\partial t}, \frac{\partial \epsilon}{\partial t}, \frac{\partial \mu}{\partial t} = 0$$

$$(\vec{E}, \psi) = \hat{\xi}(\vec{r}) \cdot T(t)$$

Helmholtz equation:

$$[\Delta + k_0^2 n^2]\hat{\xi} = 0$$

Contains all information about the media

Fundamental solution for homogeneous media

$$\hat{\xi} = \hat{A}exp(i\vec{k}\cdot\vec{r}), \left|\vec{k}\right|^2 = k_0^2n^2$$



Plane wave in semi-infinite media

Helmholtz equation:

$$[\Delta + k^2]\hat{\xi} = 0$$

 Doing separation of variables once again:

$$\hat{\xi}(\vec{r}) = \hat{A}e^{i(k_x \cdot x + k_y \cdot y)} \xi_z(z)$$

$$\frac{d^2 \xi_z}{dz^2} + k_z^2(z)\xi_z = 0$$

Generic solution:

$$\xi_{zl}(z) = t_l e^{ik_{zl}z} + r_l e^{-ik_{zl}z}$$

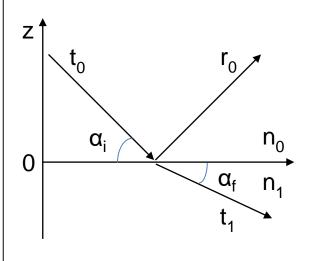
• Boundary conditions:

$$t_0 = 1$$

$$r_1 = 0$$

$$\hat{\xi}(z = 0 +) = \hat{\xi}(z = 0 -)$$

$$\frac{\partial \hat{\xi}}{\partial z}(z = 0 +) = \frac{\partial \hat{\xi}}{\partial z}(z = 0 -)$$



Important implications

Fresnel's formulas:

$$R = |r_0|^2 = \left| \frac{k_{z0} - k_{z1}}{k_{z0} + k_{z1}} \right|^2, T = |t_1|^2 = \left| \frac{2k_{z0}}{k_{z0} + k_{z1}} \right|^2$$

Snell's law:

$$\frac{\cos \alpha_i}{\cos \alpha_f} = \frac{n_1}{n_0}, \cos \alpha_{i,c} = \frac{n_1}{n_0}$$



Matrix formalism for multi-layer systems

Generic solution for z-component:

Seneric solution for z-component:
$$\xi_{zl}(z) = t_l e^{ik_{zl}(z-\mathbf{p}_{l-1})} + r_l e^{-ik_{zl}(z-\mathbf{p}_{l-1})}, \qquad l=1,...,i$$

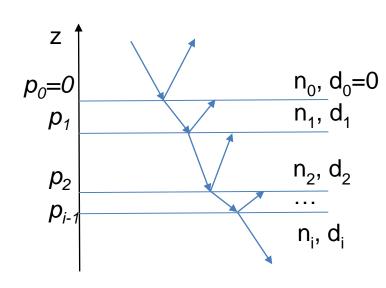
$$\xi_{z0}(z) = t_0 e^{ik_{z0}z} + r_0 e^{-ik_{z0}z}$$

Boundary conditions:

$$t_0 = 1, r_i = 0$$

$$\xi_{zl-1}(p_l +) = \xi_{zl}(p_l -)$$

$$\frac{\partial \xi_{zl-1}}{\partial z}(p_l +) = \frac{\partial \xi_{zl}}{\partial z}(p_l -)$$



Backward matrix relation:

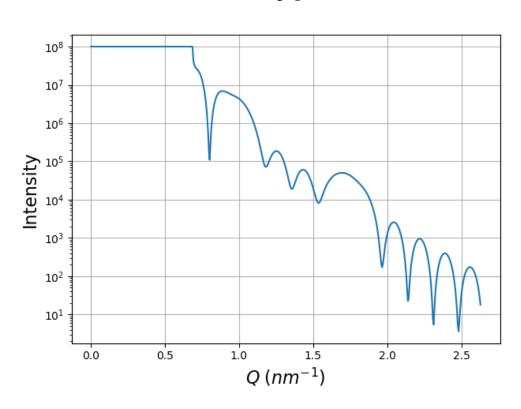
$$\begin{pmatrix} t_{l-1} \\ r_{l-1} \end{pmatrix} = \begin{pmatrix} \exp(-ik_{zl-1}d_{l-1}) & 0 \\ 0 & \exp(ik_{zl-1}d_{l-1}) \end{pmatrix} \frac{1}{2k_{zl-1}} \begin{pmatrix} k_{zl-1} + k_{zl} & k_{zl-1} - k_{zl} \\ k_{zl-1} - k_{zl} & k_{zl-1} + k_{zl} \end{pmatrix} \begin{pmatrix} t_l \\ r_l \end{pmatrix}$$

Phase shift

"Sewing" amplitudes together

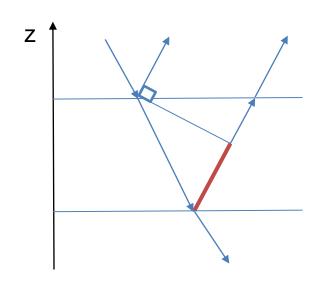


Typical reflectometry image



Scattering wave vector:

$$Q = 2k_{z0} = \frac{4\pi}{\lambda} \sin \alpha_i$$



Interference maximum:

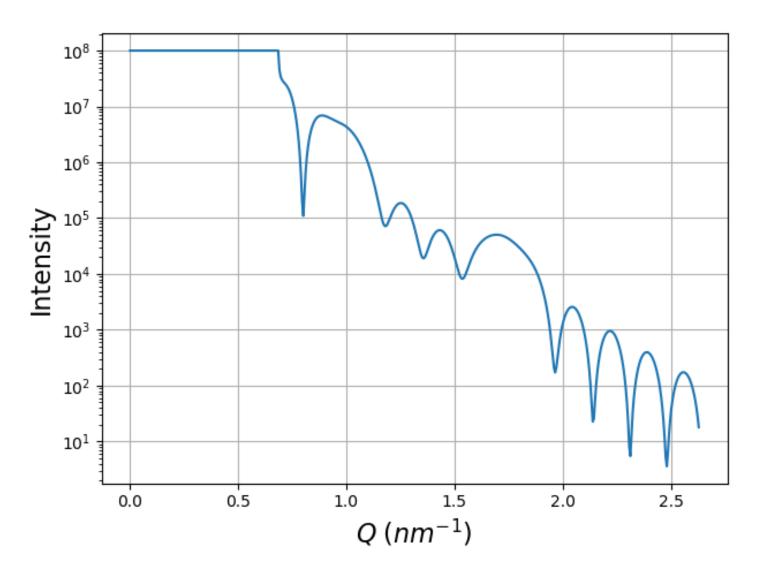
$$\Delta \varphi = 2d \sin \alpha_i = \lambda$$

Peak width:

$$\delta Q \approx \frac{2\pi}{d}$$

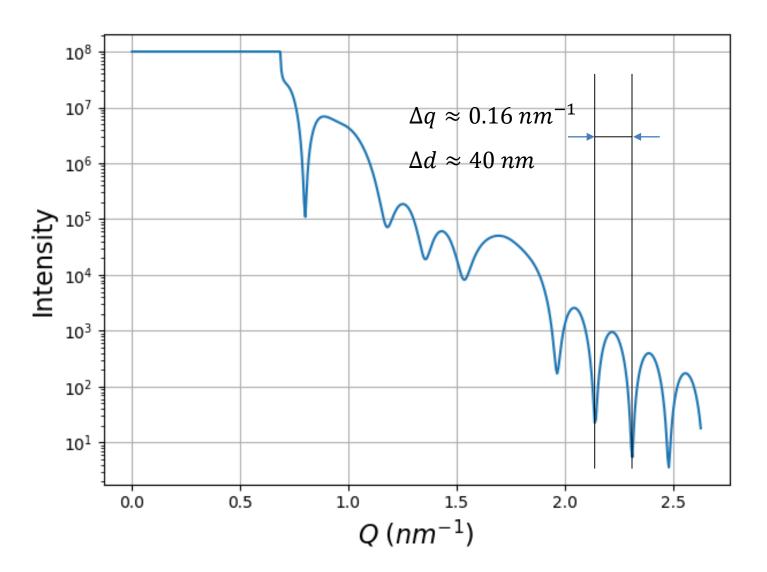


Task: sample thickness from reflectometry image





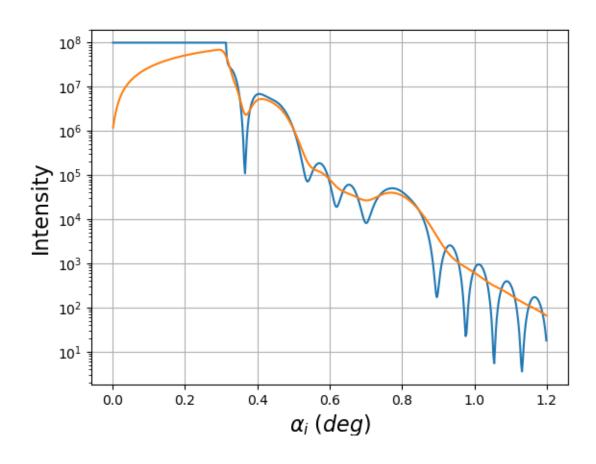
Task: sample thickness from reflectometry image





Beam effects: overview

- Footprint correction
- Beam divergence
- Background noise





Beam effects: footprint correction

Depends on beam-to-sample width ratio

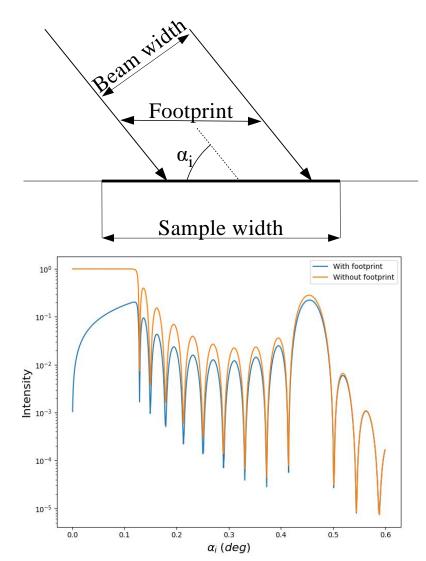
$$Z = \frac{W_{beam}}{W_{sample}}$$

Gaussian beam

$$F_G(R, \alpha_i) = \operatorname{erf}\left(\frac{\sin \alpha_i}{\sqrt{2} Z}\right)$$

Square beam

$$F_S(R, \alpha_i) = \min\left(\frac{\sin \alpha_i}{Z}, 1\right)$$





Beam effects: divergence

Total divergence impact on q:

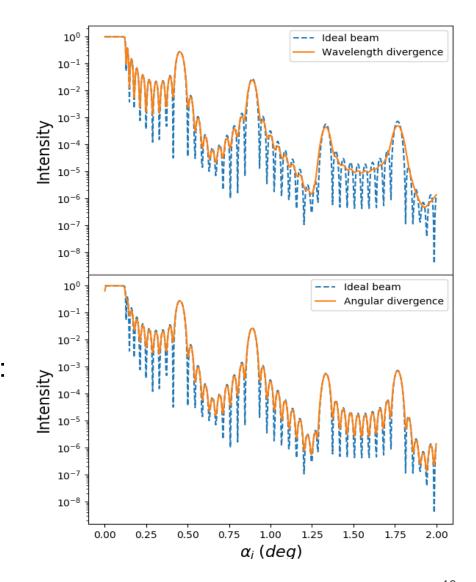
$$\Delta Q = \sqrt{Q^2 \left(\frac{\Delta \lambda}{\lambda}\right)^2 + \left(\frac{4\pi}{\lambda} \cos \alpha_i \cdot \Delta \alpha_i\right)^2}$$

Wavelength divergence at small angles:

$$\Delta Q(\Delta \lambda = 0, \alpha_i \ll 1) \approx \frac{4 \pi}{\lambda} \Delta \alpha_i$$

Angular divergence at small angles:

$$\Delta Q(\Delta \alpha_i = 0, \alpha_i \ll 1) \approx \frac{4 \pi}{\lambda} \alpha_i \frac{\Delta \lambda}{\lambda}$$





Materials: index of refraction vs SLD

Index of refraction

$$n = 1 - \delta + i\beta$$

- Depends on wavelength
- X-ray data at http://henke.lbl.gov/optical_constants/getdb2.html

Scattering length density (SLD)

$$n^2 = 1 - \frac{\lambda^2}{\pi} \rho$$
, $\rho = \rho_r - i\rho_i$

- Can be interpreted as normalized potential of interaction
- Interaction with neutrons:

Neutron data at https://webapps.frm2.tum.de/intranet/neutroncalc/



Materials: index of refraction vs SLD

HomogeneousMaterial

- Based on index of refraction
- Suitable for any probe type
- Provides correct values of refractive index for a monochromatic wave with predefined wavelength
- Main use case: probes with negligible wavelength divergence

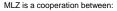
MaterialBySLD

- Based on SLD
- Provides correct values of refractive index in a range of wavelengths
- Main use case: neutron probes and materials with small signal attenuation



Reflectometry in BornAgain: tutorials

Dmitry Yurov











• Instrument:

Direct beam intensity: 10⁸

Wavelength: 0.1798 nm

Angle range: 0 − 3 deg

• Gaussian angular divergence: $\sigma = 0.01 \text{ deg}$

Square footprint: sample width – 10 cm, beam width – 0.1 mm

Sample:

Neutron data at https://webapps.frm2.tum.de/intranet/neutroncalc/

Material	Density, g/cm3	ρ _r , 10 ⁻⁶ A ⁻²	ρ _i , 10 ⁻⁶ A ⁻²	thickness, nm
Vacuum	-	0	0	Inf
Ag	4			20
SiO ₂	2.33			5
Si	2.33			Inf



Instrument:

Direct beam intensity: 10⁸

Wavelength: 0.1798 nm

Angle range: 0 − 3 deg

• Gaussian angular divergence: $\sigma = 0.01 \text{ deg}$

Square footprint: sample width – 10 cm, beam width – 0.1 mm

Sample:

Neutron data at https://webapps.frm2.tum.de/intranet/neutroncalc/

Material	Density, g/cm3	ρ _r , 10 ⁻⁶ A ⁻²	ρ _i , 10 ⁻⁶ A ⁻²	thickness, nm
Vacuum	-	0	0	Inf
Ag	4	1.322	0.004	20
SiO ₂	2.33	3.681	0	5
Si	2.33	2.074	0	Inf

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- Fitting parameters
 - Ag density
 - Ag layer thickness
 - SiO₂ density
 - SiO₂ layer thickness

Fit parameter	Start	Min	Max
Ag ρ_r , 10^{-6} A ⁻²	1.322	0.661	2.0
Ag thickness, nm	20	10	30
$SiO_2 \rho_r$, $10^{-6} A^{-2}$	3.681	3.5	4.0
SiO ₂ thickness, nm	5	3	8



- Fitting parameters
 - Ag density
 - Ag layer thickness
 - SiO₂ density
 - SiO₂ layer thickness

Fit parameter	Target value
Ag ρ_r , 10^{-6} A ⁻²	1.984
Ag thickness, nm	25
$SiO_2 \rho_r$, $10^{-6} A^{-2}$	3.8
SiO ₂ thickness, nm	7



Thank you for your attention!







